

V_{RSM} = 2800 V
 $I_{F(AV)M}$ = 6830 A
 $I_{F(RMS)}$ = 10730 A
 I_{FSM} = 87×10^3 A
 V_{FO} = 0.8 V
 r_F = 0.05 mW

Rectifier Diode

5SDD 60N2800

Doc. No. 5SYA1155-01 Jan. 05

- Patented free-floating silicon technology
- Very low on-state losses
- Optimum power handling capability

Blocking

Maximum rated values¹⁾

Parameter	Symbol	Conditions	Value	Unit
Repetitive peak reverse voltage	V_{RRM}	$f = 50$ Hz, $t_p = 10$ ms, $T_j = 160^\circ\text{C}$	2000	V
Non-repetitive peak reverse voltage	V_{RSM}	$f = 5$ Hz, $t_p = 10$ ms, $T_j = 160^\circ\text{C}$	2800	V

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Max. (reverse) leakage current	I_{RRM}	V_{RRM} , $T_j = 160^\circ\text{C}$			400	mA

Mechanical data

Maximum rated values¹⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Mounting force	F_M		81	90	108	kN
Acceleration	a	Device unclamped			50	m/s^2
Acceleration	a	Device clamped			100	m/s^2

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Weight	m				2.8	kg
Housing thickness	H	$F_M = 90$ kN, $T_a = 25^\circ\text{C}$	34.3		34.9	mm
Surface creepage distance	D_S		56			mm
Air strike distance	D_a		22			mm

1) Maximum rated values indicate limits beyond which damage to the device may occur

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On-state*Maximum rated values¹⁾*

Parameter	Symbol	Conditions	min	typ	max	Unit
Max. average on-state current	I _{F(AV)M}	50 Hz, Half sine wave, T _C = 90 °C			6830	A
Max. RMS on-state current	I _{F(RMS)}				10730	A
Max. peak non-repetitive surge current	I _{FSM}	t _p = 10 ms, T _j = 160°C, V _R = 0 V			87x10 ³	A
Limiting load integral	I ² t				38.5x10 ⁶	A ² s
Max. peak non-repetitive surge current	I _{FSM}	t _p = 8.3 ms, T _j = 160°C, V _R = 0 V			95x10 ³	A
Limiting load integral	I ² t				38x10 ⁶	A ² s

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
On-state voltage	V _F	I _F = 5000 A, T _j = 160°C			1.05	V
Threshold voltage	V _(TO)	T _j = 160°C I _T = 2500...7500 A			0.8	V
Slope resistance	r _T				0.05	mΩ

Switching*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Recovery charge	Q _{rr}	dI _F /dt = -10 A/μs, V _R = 200 V I _{FRM} = 4000 A, T _j = 160°C			6300	μAs

Thermal

Maximum rated values¹⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Operating junction temperature range	T _{vj}				160	°C
Storage temperature range	T _{stg}		-40		175	°C

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Thermal resistance junction to case	R _{th(j-c)}	Double-side cooled F _m = 81...108 kN			5.7	K/kW
	R _{th(j-c)A}	Anode-side cooled F _m = 81...108 kN			11.4	K/kW
	R _{th(j-c)C}	Cathode-side cooled F _m = 81...108 kN			11.4	K/kW
Thermal resistance case to heatsink	R _{th(c-h)}	Double-side cooled F _m = 81...108 kN			1	K/kW
	R _{th(c-h)}	Single-side cooled F _m = 81...108 kN			2	K/kW

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_{th i} (1 - e^{-t/\tau_i})$$

i	1	2	3	4
R _{th i} (K/kW)	3.731	1.250	0.434	0.292
τ _i (s)	0.8113	0.1014	0.0089	0.0015

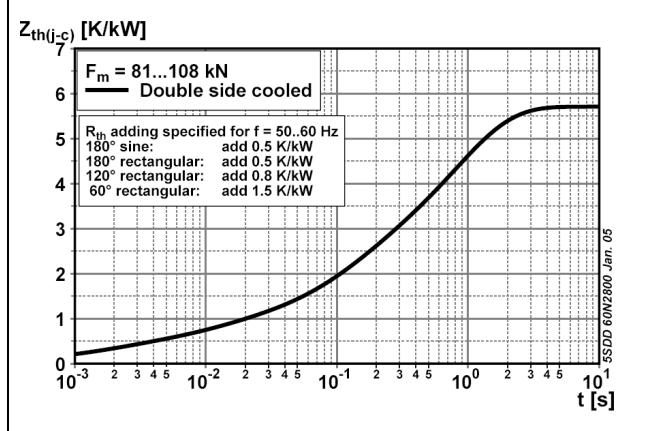
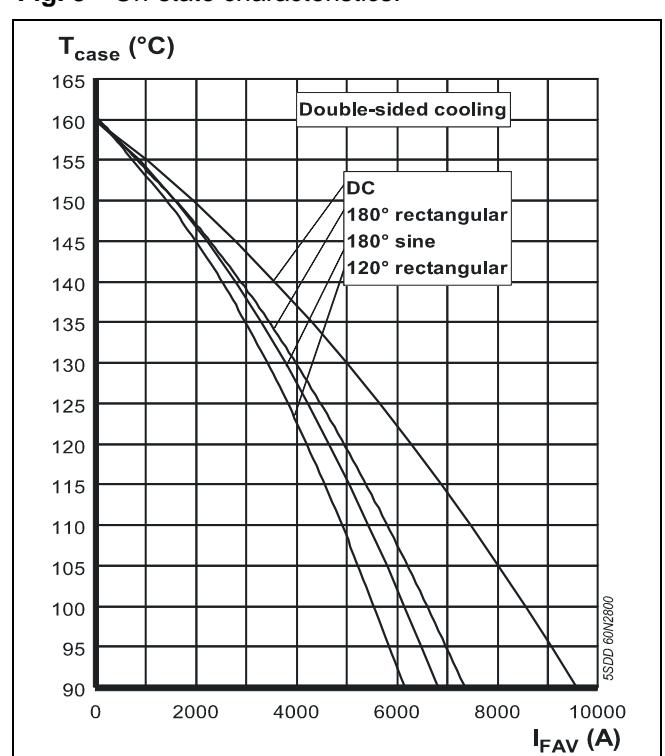
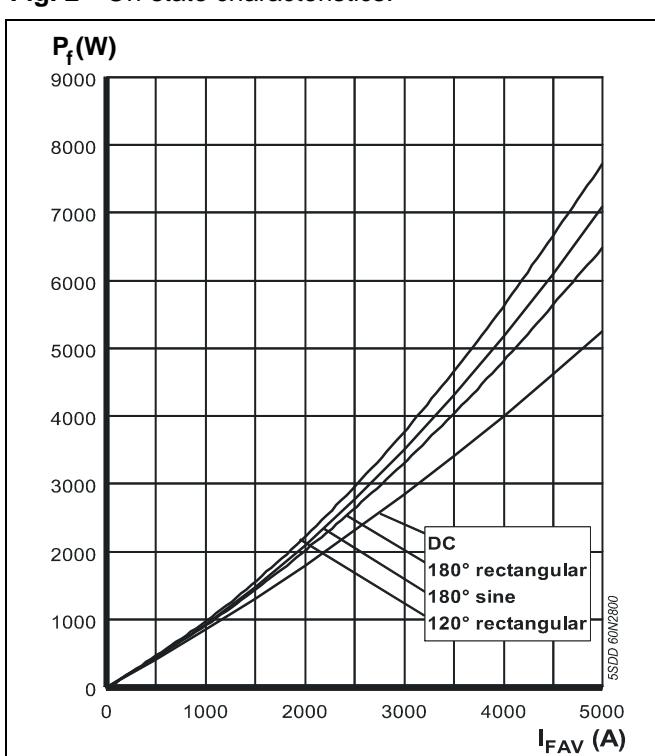
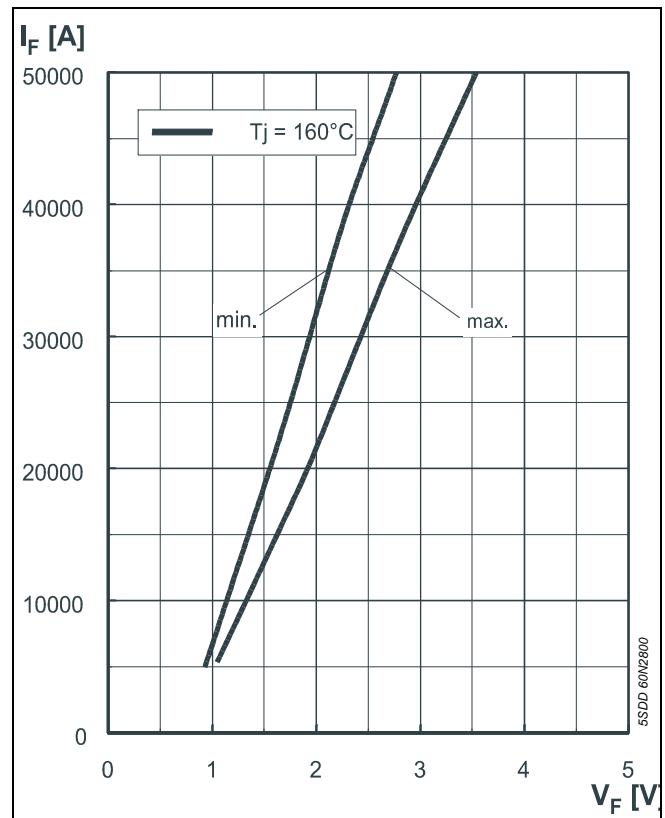
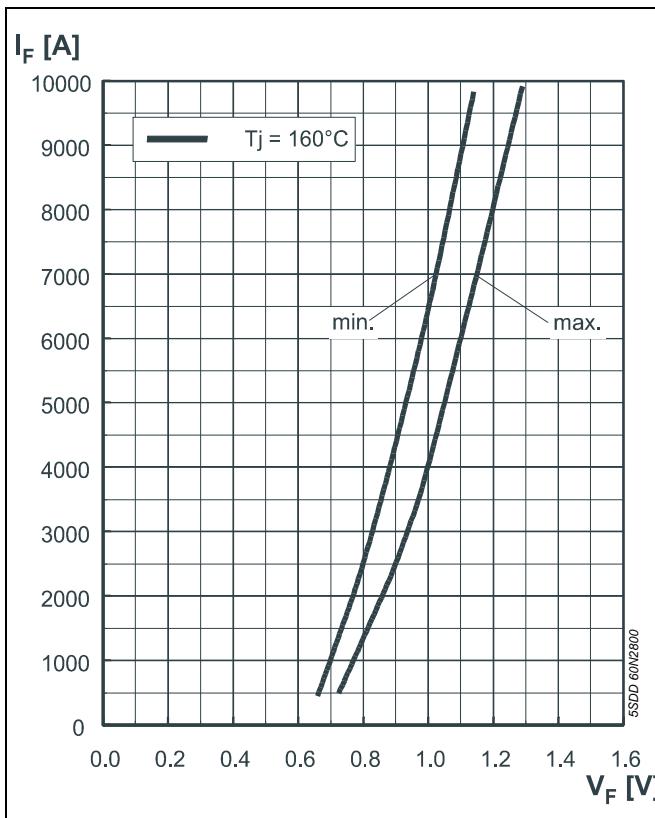
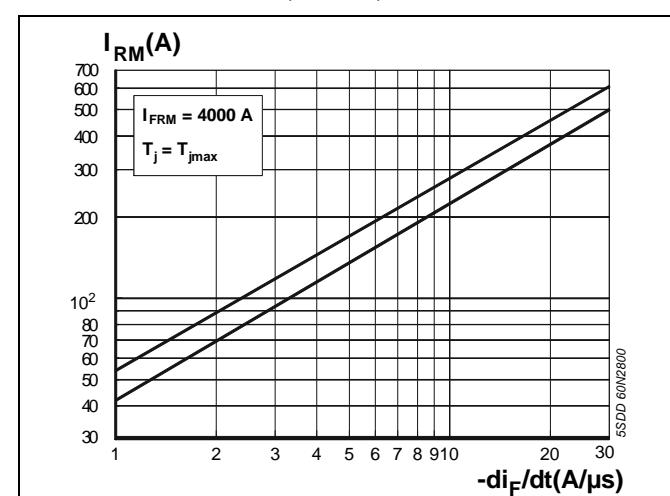
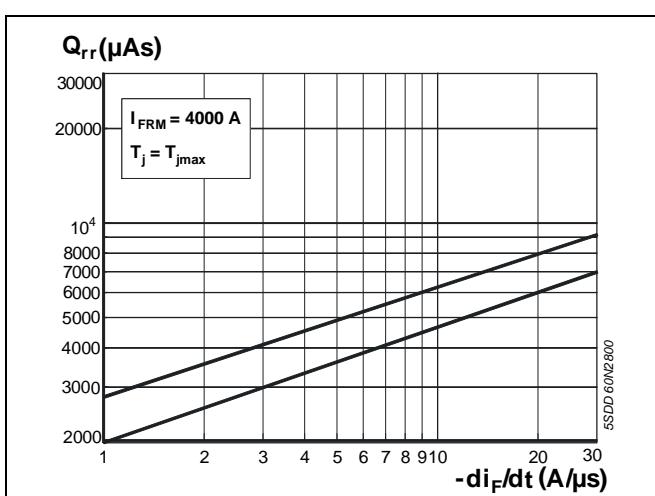
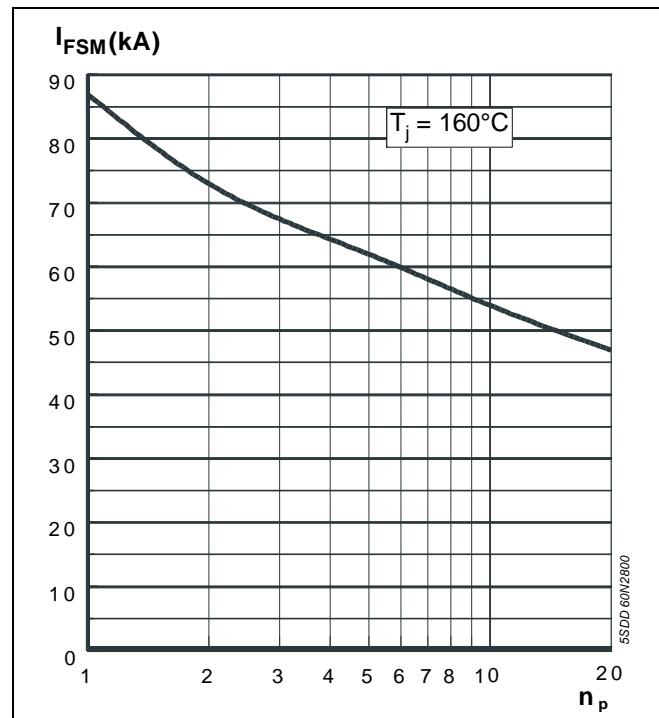
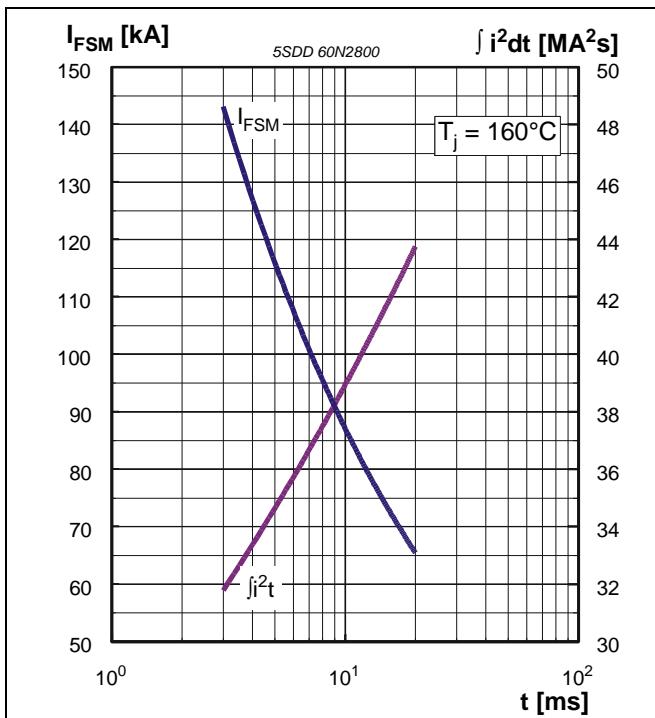


Fig. 1 Transient thermal impedance junction-to-case.





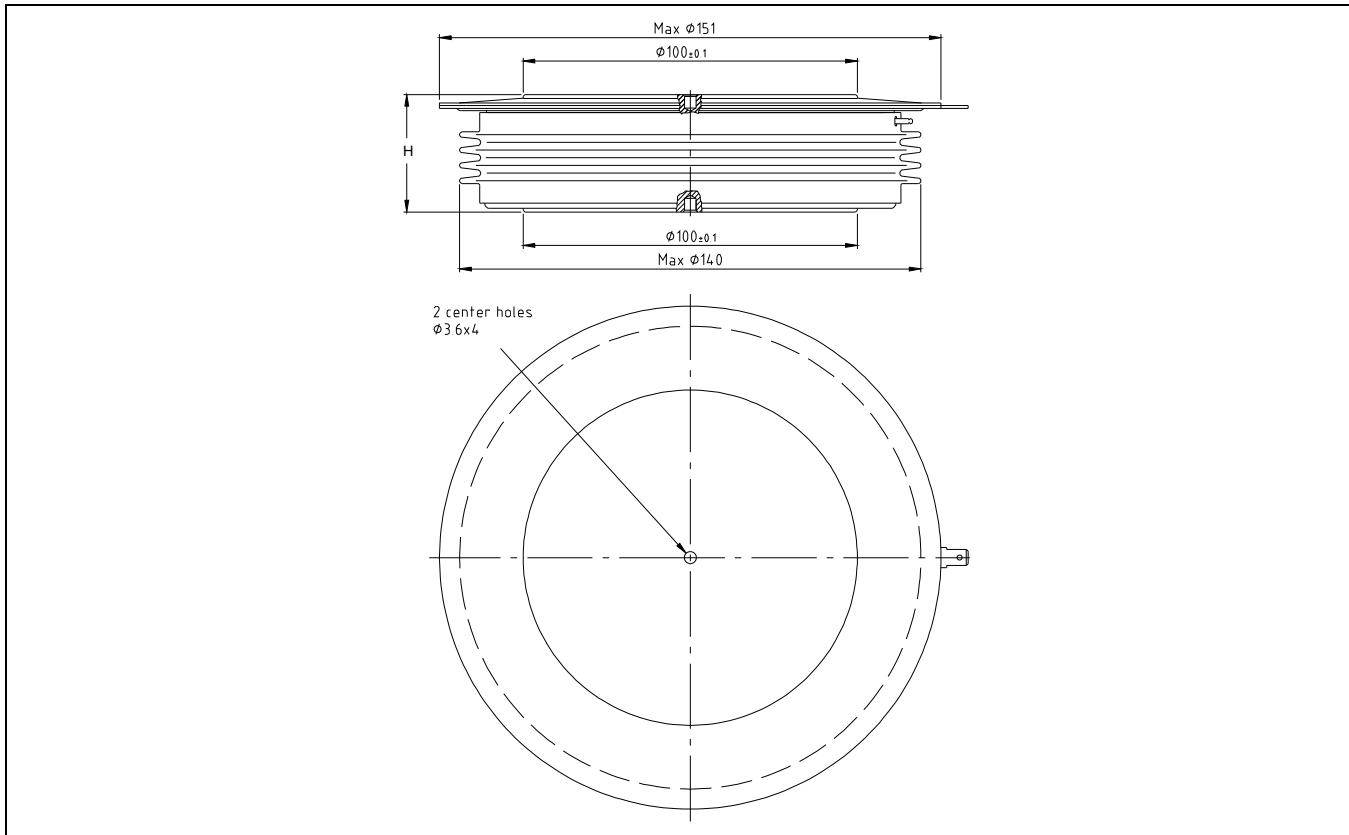


Fig. 10 Outline drawing. All dimensions are in millimeters and represent nominal values unless stated otherwise.

Related application notes:

Doc. Nr	Titel
5SYA 2020	Design of RC-Snubbers for Phase Control Applications
5SYA 2029	Designing Large Rectifiers with High Power Diodes
5SYA 2036	Recommendations regarding mechanical clamping of Press Pack High Power Semiconductors

Please refer to <http://www.abb.com/semiconductors> for actual versions.

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ABB Switzerland Ltd
Semiconductors
Fabrikstrasse 3
CH-5600 Lenzburg, Switzerland

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Telephone +41 (0)58 586 1419
Fax +41 (0)58 586 1306
Email abbsem@ch.abb.com
Internet www.abb.com/semiconductors